### SN74AS303 OCTAL DIVIDE-BY-2 CIRCUITS/CLOCK DRIVERS

Q3  $\Pi$ 

Q4

GND 3

GND 4

GND∏ 5

Q5¶ 6

Q6[] 7 Q7[] 8

SN74AS303...D<sup>†</sup> OR N PACKAGE

(TOP VIEW)

16 Q2

15 Q1

14 CLR

13 VCC

12 VCC

10 PRE

Q8

D3543, JULY 1990

- Maximum Output Skew of 1 ns
- Maximum Pulse Skew of 1 ns
- Center-Pin V<sub>CC</sub> and GND Configurations to Minimize High-Speed Switching Noise
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

### description

The SN74AS303 contains eight flip-flops designed to have low skew between outputs. The

† Contact factory for information on availability of S.O. package.

eight outputs (six in-phase with CLK and two out-of-phase) toggle on successive CLK pulses.  $\overline{PRE}$  and  $\overline{CLR}$  inputs are provided to set the Q and  $\overline{Q}$  outputs high or low independent of the CLK pin.

The 'AS303 has output and pulse skew parameters  $t_{sk(0)}$  and  $t_{sk(p)}$  to ensure performance as a clock driver when a divide-by-two function is required.

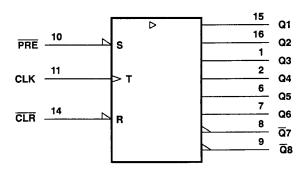
The SN74AS303 is characterized for operation from 0°C to 70°C.

#### **FUNCTION TABLE**

INPUTS			OUTPUTS		
CLR PRE CLK		Q1-Q6	<u>Q</u> 7– <u>Q</u> 8		
L	Н	Х	L	Н	
Н	L	X	Н	L	
L.	L	×	L‡	L‡	
н	Н	<b>†</b>	$\overline{Q}_0$	$Q_0$	
Н	Н	L	$Q_0$	$\overline{Q}_0$	

<sup>†</sup> This configuration will not persist when PRE or CLR returns to its inactive (high) level.

## logic symbol§

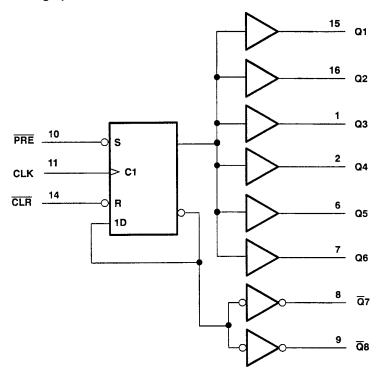


<sup>§</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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# SN74AS303 OCTAL DIVIDE-BY-2 CIRCUITS/CLOCK DRIVERS

# logic diagram (positive logic)



# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage, V <sub>CC</sub>
Input voltage, V <sub>1</sub> 7 V
Operating free-air temperature range 0°C to 70°C
Storage temperature range – 65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. This are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
ЮН	High-level output current			- 24	mA
IOL	Low-level output current			48	mA
TA	Operating free-air temperature	0		70	°C

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CON	DITIONS	MIN TYPT	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	l <sub>l</sub> = – 18 mA		- 1.2	V
	V <sub>CC</sub> = 4.5 V to 5.5 V,	I <sub>OH</sub> = – 2 mA	V <sub>CC</sub> <sup>-2</sup>		V
VOH	V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = 24 mA	2 2.8		<b>V</b>
VoL	V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 48 mA	0.3	0.5	V
1	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V		0.1	mA
<sup>1</sup> IH	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V		20	μΑ
I <sub>IL</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V		- 0.5	mA
10 <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	- 50	- 150	mA
¹cc	V <sub>CC</sub> = 5.5 V,	See Note 1	40	70	mA

#### timing requirements

		PARAMETER	MIN	MAX	UNIT
fclock	Clock frequency		0 80	80	MHz
		CLR or PRE low	5		
tw	Pulse duration	CLK high	4		ns
		CLK low	6		
tsu	Setup time before CLK↑	CLR or PRE inactive	6		ns

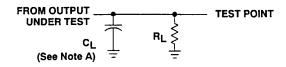
# switching characteristics over recommended operating free-air temperature range (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	MAX	UNIT
f <sub>max</sub> §				80		MHz
<sup>t</sup> PLH		Q, $\overline{Q}$		2	9	ns
<sup>†</sup> PHL	CLK	Q, Q	$R_L = 500 \Omega$ , $C_L = 50 pF$	2	9	ns
†PLH		_ =		3	12	ns
t <sub>PHL</sub>	PRE or CLR	$\overline{A}$ Q, $\overline{Q}$ $R_L = 500 \Omega$ , $C_L = 50 pF$		3	12	ns
		Q			1	
<sup>t</sup> sk(o)	CLK	ā	$R_L = 500 \Omega$ , $C_L = 10 pF to 30 pF$		1	ns
. (,,	1	Q, $\overline{Q}$			2	
tsk(p)	CLK	Q, Q	$R_L = 500 \Omega$ , $C_L = 10  pF \text{ to } 30  pF$		1	ns
t <sub>r</sub>					4.5	ns
tf					3.5	ns

 $<sup>\</sup>S$  f<sub>max</sub> minimum values are at C<sub>L</sub> = 0 to 30 pF.

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I<sub>OS</sub>. NOTE 1: I<sub>CC</sub> is measured with CLK and PRE grounded, then with CLK and CLR grounded.

### PARAMETER MEASUREMENT INFORMATION



#### **LOAD CIRCUIT**

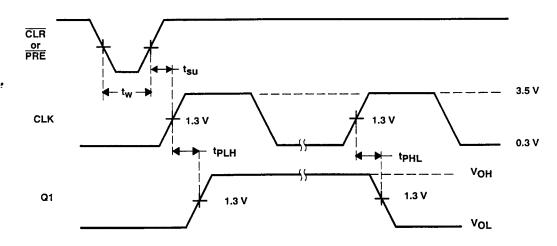
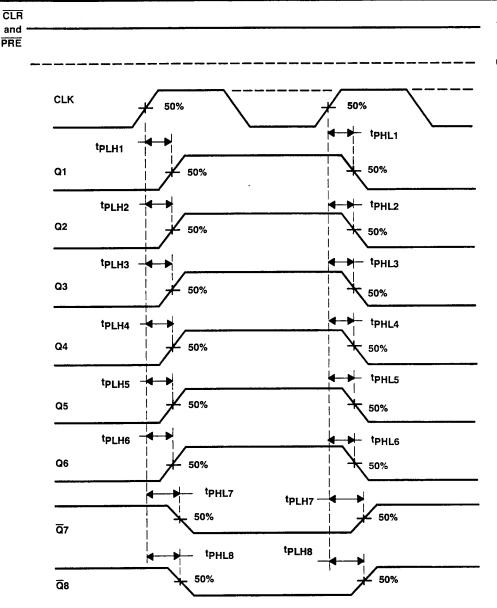


Figure 1. Load Circuit and Voltage Waveforms

NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

B. Input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $t_r = 2.5$  ns,  $t_f = 2.5$  ns.



- NOTES: A.  $t_{sk(0)}$ , CLK to Q, is calculated as the greater of: 1. The difference between the fastest and slowest of  $t_{PLHn}$  ( n = 1, 2, 3, 4, 5, 6), and
  - 2. the difference between the fastest and slowest of  $tp_{HLn}$  ( n = 1, 2, 3, 4, 5, 6).
  - B.  $t_{SK(0)}$ , CLK to  $\overline{Q}$ , is calculated as the greater of:  $|t_{PLH7} t_{PLH8}|$  and  $|t_{PHL7} t_{PHL8}|$ .
  - C.  $t_{sk(0)}$ , CLK to Q and  $\overline{Q}$ , is calculated as the greater of:
    - 1. The difference between the fastest and slowest of tpLHn (n = 1, 2, 3, 4, 5, 6), tpHL7, and tpHL8, and
    - 2. the difference between the fastest and slowest of tpHLn (n = 1, 2, 3, 4, 5, 6), tpLH7, and tpLH8.
  - D.  $t_{sk(p)}$  is calculated as the greater of  $|t_{PLHn} t_{PHLn}|$  ( n = 1, 2, 3, ..., 8 ).

Figure 2. Waveforms for Calculation of t<sub>sk(o)</sub>







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#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74AS303D	OBSOLETE	SOIC	D	16	TBD	Call TI	Call TI
SN74AS303N	OBSOLETE	PDIP	N	16	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in

a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <a href="http://www.ti.com/productcontent">http://www.ti.com/productcontent</a> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

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(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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